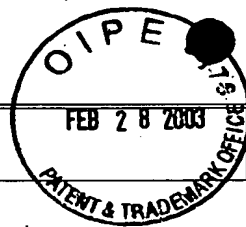
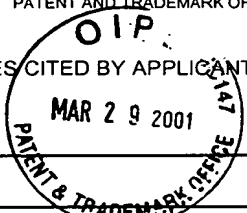


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 201034US0PCT		SERIAL NO. 09/720,262	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Akira IGARASHI, et al.			
				FILING DATE February 6, 2001		GROUP 1754	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	2000-302410	10/31/00	JAPAN (corr. to EP 1 046 612 A1)			XX
	AP	EP 1 046 612 A1	10/25/00	EUROPE			
	AQ						
	AR						
	AS						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
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	AZ						
Examiner					Date Considered		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							



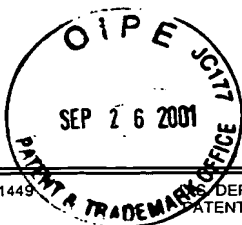
Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 201034US0PCT		SERIAL NO. 09/720,262	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Akira IGARASHI, et al.			
				FILING DATE February 6, 2001		GROUP 1754	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	5,989,457	11/23/99	SESHAN et al. (Corrp. To CN 1121701)			
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	DE-2057839	06/16/71	GERMANY (w/English Abstract) Corrp. to GB 1 332 349			
	AP	GB 1 332 349	10/03/73	GREAT BRITAIN (Corrp. To DE-2057839)			
	AQ	CN 1121701	05/01/96	CHINA (w/English Abstract) Corrp. To US 5,989,457			
	AR						
	AS						
	AT						
	AU						
	AV						
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW	Chinese Office Action of January 31, 2003 (w/English translation)					
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner					Date Considered		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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LIST OF REFERENCES CITED BY APPLICANT <div style="text-align: center;">  </div>				APPLICANT Akira IGARASHI, et al.			
				FILING DATE February 6, 2001		GROUP 1754	
U.S. PATENT DOCUMENTS							
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	AO	2000-119004	04/25/2000	JAPAN			
	AP	0 985 635	03/15/2000	EUROPE (corr. JP 2000-119004)			
	AQ	0 861 802	09/02/98	EUROPE			
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	AZ						
Examiner					Date Considered		

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				FILING DATE February 6, 2001		GROUP 1754	
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
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	AP	911136	10/03/72	CANADA			
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